


<b>Search Notes</b>  	<b>Application/Control No.</b>  10582959	<b>Applicant(s)/Patent Under Reexamination</b>  TAKAMATSU ET AL.
	<b>Examiner</b>  Stefan Krueer	<b>Art Unit</b>  3654

SEARCHED			
Class	Subclass	Date	Examiner
242	374	06/08/2008	SHK

SEARCH NOTES		
Search Notes	Date	Examiner
PLUS	06/08/2008	SHK
Application having common co-inventor(s)		
Backward/forward citations of prior art	12/04/2008	SHK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--